

**Search Notes****Application/Control No.**

10/692,269

**Examiner**

HABTE MERED

**Applicant(s)/Patent under Reexamination**

LIAO ET AL.

**Art Unit**

2474

**SEARCHED**

Class	Subclass	Date	Examiner
370	230	11/6/2009	HM
370	230.1	11/6/2009	HM
370	231	11/6/2009	HM
370	232	11/6/2009	HM
370	233	11/6/2009	HM
370	234	11/6/2009	HM
370	449	11/6/2009	HM
709	225-229	11/6/2009	HM
455	450	11/6/2009	HM
455	452.1	11/6/2009	HM
455	452.2	11/6/2009	HM
455	453	11/6/2009	HM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched East DB:USPAT, USPG-Pub, EPO and JPO	11/6/2009	HM
Searched IEEE	5/14/2009	HM
Searched Palm Inventor's DB	5/14/2009	HM
Consulted with SPE (A. Moe) on rejection strategy and allowable subject matter	5/12/2009	HM